

# Notices

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This section of the FEDERAL REGISTER contains documents other than rules or proposed rules that are applicable to the public. Notices of hearings and investigations, committee meetings, agency decisions and rulings, delegations of authority, filing of petitions and applications and agency statements of organization and functions are examples of documents appearing in this section.

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## COMMISSION ON CIVIL RIGHTS

### Agenda and Notice of Public Meeting of the Tennessee Advisory Committee

Notice is hereby given, pursuant to the provisions of the rules and regulations of the U.S. Commission on Civil Rights (Commission) and the Federal Advisory Committee Act (FACA), that a meeting of the Tennessee Advisory Committee to the Commission (Committee) will convene at 1:30 p.m. and adjourn at about 3 p.m. on Monday, August 24, 2009, at the Disabled Student Services Center, Keathley University Center, Middle Tennessee State University, Tennessee, 37132. The purpose of the meeting is for the Committee to plan future projects for fiscal year 2010.

Members of the public are entitled to submit written comments. The comments must be received in the regional office by September 24, 2009. The mailing address is: Southern Regional Office, U.S. Commission on Civil Rights, 61 Forsyth St., SW., Suite 18T40, Atlanta, GA 30303. Persons wishing to e-mail their written comments may do so to [pminari@usccr.gov](mailto:pminari@usccr.gov). Persons who desire additional information should contact the Southern Regional Office, at (404) 562-7000, or by e-mail at [pminarik@usccr.gov](mailto:pminarik@usccr.gov).

Hearing-impaired persons who will attend the meetings and require the services of a sign language interpreter should contact the Regional Office at least ten (10) working days before the scheduled date of the meeting.

Records generated from these meetings may be inspected and reproduced at the Southern Regional Office, as they become available, both before and after the meeting. Persons interested in the work of this advisory committee are advised to go to the Commission's Web site, <http://www.usccr.gov>, or to contact the

Southern Regional Office at the above e-mail or street address.

The meeting will be conducted pursuant to the provisions of the rules and regulations of the Commission and FACA.

Dated in Washington, DC, July 27, 2009.

**Peter Minarik,**

*Acting Chief, Regional Programs  
Coordination Unit.*

[FR Doc. E9-18207 Filed 7-29-09; 8:45 am]

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## DEPARTMENT OF COMMERCE

### International Trade Administration

#### Application(s) for Duty-Free Entry of Scientific Instruments

Pursuant to Section 6(c) of the Educational, Scientific and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, as amended by Pub. L. 106-36; 80 Stat. 897; 15 CFR part 301), we invite comments on the question of whether instruments of equivalent scientific value, for the purposes for which the instruments shown below are intended to be used, are being manufactured in the United States. Comments must comply with 15 CFR 301.5(a)(3) and (4) of the regulations and be postmarked on or before August 19, 2009. Address written comments to Statutory Import Programs Staff, Room 3720, U.S. Department of Commerce, Washington, D.C. 20230. Applications may be examined between 8:30 A.M. and 5:00 P.M. at the U.S. Department of Commerce in Room 3720.

*Docket Number: 09-019.* Applicant: University of Oklahoma, Mewbourne School of Petroleum and Geological Engineering, 100 E Boyd St., Suite T-301, Norman, OK 73019. Instrument: Electron Microscope. Manufacturer: FEI Company, the Netherlands. Intended Use: The instrument will be used to study the three dimensional nano-pore structure of geologic material. Justification for Duty-Free Entry: No instruments of same general category are manufactured in the United States. Application accepted by Commissioner of Customs: July 1, 2009.

*Docket Number: 09-027.* Applicant: National Renewable Energy Laboratory, 1617 Cole Blvd., Golden, GO 80401. Instrument: Electron Microscope. Manufacturer: FEI Company, Czech

Republic. Intended Use: The instrument will be used to characterize the crystallography and structural morphology of materials used in the development of photovoltaic (solar cell) semiconductor devices. It will also be used in the analysis of a variety of nano-structured materials. Justification for Duty-Free Entry: No instruments of same general category are manufactured in the United States. Application accepted by Commissioner of Customs: May 18, 2009.

*Docket Number: 09-042.* Applicant: Temple University Hospital, 3401 N. Broad St., 2nd Floor, Zone A, Philadelphia, PA 19140. Instrument: Electron Microscope. Manufacturer: JEOL, Japan. Intended Use: The instrument will be used to perform ultrastructural analysis of the components in the diagnosis of renal diseases. Specifically it will be used to identify certain genetic diseases that alter cellular structural proteins. Justification for Duty-Free Entry: No instruments of same general category are manufactured in the United States. Application accepted by Commissioner of Customs: July 2, 2009.

*Docket Number: 09-043.* Applicant: University of Central Florida, 4000 Central Florida Blvd. MAP 310, Orlando, FL 32816. Instrument: Electron Microscope. Manufacturer: Tescan, s.r.o., Czech Republic. Intended Use: The instrument will be used to study the properties of sp<sup>2</sup>-bonded nanostructures with unusual mechanical, electrical and thermal properties, such as those composed of boron, carbon and nitrogen. Justification for Duty-Free Entry: No instruments of same general category are manufactured in the United States. Application accepted by Commissioner of Customs: July 16, 2009.

*Docket Number: 09-044.* Applicant: Missouri State University, 901 S. National Ave., Springfield Missouri 65897. Instrument: Electron Microscope. Manufacturer: FEI Company, Czech Republic. Intended Use: The instrument will be used to study the correlations between morphology, structures and compositions of various materials as well as their electrical, optical, magnetic and biological properties. Justification for Duty-Free Entry: No instruments of same general category are manufactured in the United States. Application